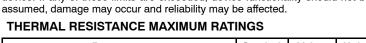
MOSFET – Power, Single, N-Channel, 40 V, 3.9 mΩ, 88 A

Features

- Low R_{DS(on)} to Minimize Conduction Losses
- Low Q_G and Capacitance to Minimize Driver Losses
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

Parameter			Symbol	Value	Unit	
Drain-to-Source Voltage			V _{DSS}	40	V	
Gate-to-Source Voltage			V _{GS}	±20	V	
Continuous Drain Cur-		$T_{C} = 25^{\circ}C$	Ι _D	84	А	
rent $R_{\theta JC}$ (Notes 1 & 3)	Steady State	$T_{\rm C} = 100^{\circ}{\rm C}$		60		
Power Dissipation $R_{\theta JC}$		$T_{C} = 25^{\circ}C$	PD	56	W	
(Note 1)		$T_{C} = 100^{\circ}C$		28	1	
Continuous Drain		$T_A = 25^{\circ}C$	Ι _D	20	A	
Current R _{θJA} (Notes 1, 2 & 3)	Steady	$T_A = 100^{\circ}C$		14		
Power Dissipation $R_{\theta JA}$	State	$T_A = 25^{\circ}C$	PD	3.1	W	
(Notes 1 & 2)		T _A = 100°C		1.5		
Pulsed Drain Current	T _A = 25°	C, t _p = 10 μs	I _{DM}	463	А	
Operating Junction and Storage Temperature			T _J , T _{stg}	-55 to 175	°C	
Source Current (Body Diode)			۱ _S	46	А	
Single Pulse Drain-to-Source Avalanche Energy (T_J = 25°C, $I_{L(pk)}$ = 8.3 A)			E _{AS}	205	mJ	
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			ΤL	260	°C	

Ν



Parameter	Symbol	Value	Unit
Junction-to-Case (Drain) (Note 1)	$R_{\theta JC}$	2.7	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	48.4	

1. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted. 2. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.

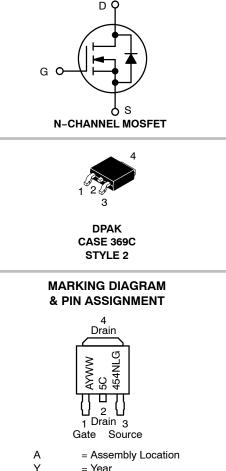
3. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.



ON Semiconductor®

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V _{(BR)DSS}	R _{DS(on)}	ID
40 V	3.9 mΩ @ 10 V	88 A
	$5.7~\mathrm{m}\Omega$ @ $4.5~\mathrm{V}$	00 A



= Year

WW = Work Week

5C454NL = Device Code G

= Pb-Free Package

ORDERING INFORMATION

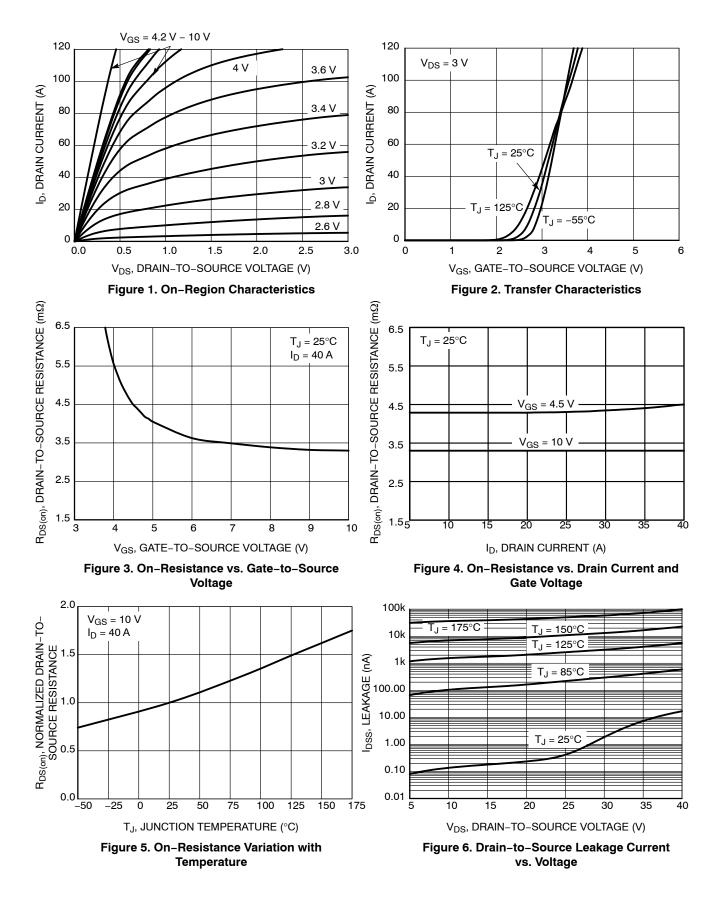
See detailed ordering and shipping information on page 5 of this data sheet.

ELECTRICAL CHARACTERISTICS (T_J = $25^{\circ}C$ unless otherwise noted)

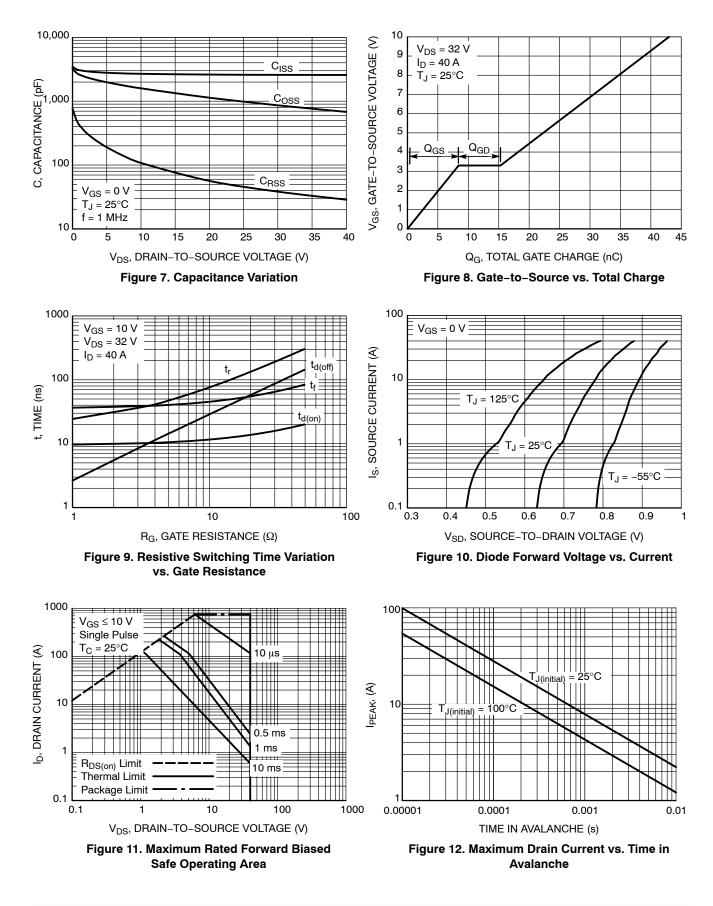
Parameter	Symbol	Test Condition		Min	Тур	Мах	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V_{GS} = 0 V, I_D = 250 μ A		40			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				11		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	I_{DSS} $V_{CS} = 0 V$ $T_J = 25^{\circ}C$				10	μA
	VGS = 0 V,	T _J = 125°C			250		
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 V, V_{GS}$	_S = 20 V			100	nA
ON CHARACTERISTICS (Note 4)						-	-
Gate Threshold Voltage	V _{GS(TH)}	V _{GS} = V _{DS} , I _D = 70 μA		1.2		2.2	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				5.2		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 4.5 V, I _D = 40 A			4.5	5.7	mΩ
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V, I _D) = 40 A		3.3	3.9	mΩ
Forward Transconductance	9FS	V _{DS} = 3 V, I _D = 40 A			106		S
CHARGES, CAPACITANCES AND GATE RE	SISTANCES						
Input Capacitance	C _{iss}	V _{GS} = 0 V, f = 1.0 MHz, V _{DS} = 25 V			2600		pF
Output Capacitance	C _{oss}				1000		-
Reverse Transfer Capacitance	C _{rss}				43		
Total Gate Charge	Q _{G(TOT)}	V_{GS} = 4.5 V, V_{DS} = 32 V, I _D = 40 A			21		nC
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 32 V, I _D = 40 A			43		nC
Threshold Gate Charge	Q _{G(TH)}				4.5		
Gate-to-Source Charge	Q _{GS}				8.4		
Gate-to-Drain Charge	Q _{GD}				6.9		1
Plateau Voltage	V _{GP}				3.3		V
SWITCHING CHARACTERISTICS (Note 5)							
Turn-On Delay Time	t _{d(on)}	V_{GS} = 10 V, V_{DS} = 32 V, I_{D} = 40 A, R_{G} = 2.5 Ω			10		ns
Rise Time	t _r				38		-
Turn-Off Delay Time	t _{d(off)}				33		
Fall Time	t _f				7		
DRAIN-SOURCE DIODE CHARACTERISTIC	S				•		
Forward Diode Voltage	V _{SD}	$V_{GS} = 0 V,$ $I_S = 40 A$	T _J = 25°C		0.88	1.2	V
-			T _J = 125°C		0.78		1
Reverse Recovery Time	t _{RR}		1		43		ns
Charge Time	ta	Vaa - 0 V die/dt	- 100 A/us		21		1
Discharge Time	tb	V_{GS} = 0 V, dls/dt = 100 A/µs, I_S = 40 A			21		1
Reverse Recovery Charge	Q _{RR}				30		nC

Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS

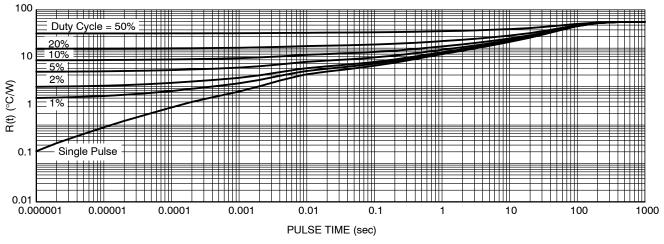


Figure 13. Thermal Response

ORDERING INFORMATION

Order Number	Package	Shipping [†]
NVD5C454NLT4G	DPAK (Pb-Free)	2500 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.





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